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Polar surface of ferroelectric nanodomains in GeTe thin films

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Ferroelectrics have polar surfaces that can undergo large structural and stoichiometric modifications to be neutral. These changes can have major implications on the surface stability and physico-chemical properties. We have studied the growth and structure of ferroelectric GeTe thin films on Si(111) by a combination of scanning tunneling microscopy, low energy electron microscopy and low energy electron diffraction. We show that the GeTe growth occurs with a single epitaxy and proceeds via a step-flow mode hindered by the advance of electrically neutral step edges exhibiting triangular notches. We demonstrate the presence of ferroelectric nanodomains with in-plane component of polarization and a complex restructuring of their polar surface. 2×2 surface reconstruction, missing row reconstruction and extended 2D modulations of the surface structure are demonstrated on these nanodomains. We show that these structures stabilize the surface termination of the low-symmetry polar nanodomains.

6 damental research stimulated by their applications as 47 transport processes during thin film growth occur at sur-7 functional materials based on the existence of different 48 faces and may be strongly influenced by these surface 8 polar variants. The main factors that govern the spa- 49 modifications [18 and 19]. • tial organization of ferroelectric domains are the elastic 10 interactions that arise from the electromechanical cou-11 pling between domains and the electrostatic interactions ¹² due to local exceeding charges. The ability to synthesize ferroelectric thin films of high crystalline quality based on layer-by-layer growth techniques and to engineer the strain field via the substrate choice have made possible to exploit these interactions and discover novel phenomena. It has been demonstrated that flux-closure polar domains [1–3], vortices [4 and 5] and even skyrmions [6] could be obtained in ferroelectric materials. This has led to a renewed interest [7–9] for prior studies on incommensurate phases in ferroelectrics with the observation of one-dimensional stripe domain patterns or even more complex 2D modulations as observed in the structural phase transitions of α - β quartz [10]. The experimental studies of the structure of ferroelectric materials are mainly based on the atomic scale characterization of domain boundaries and interfaces by STEM [11] and X-ray diffraction [12 and 13]. The surface structure of ferroelectrics has been much less explored. However the surface is also a place where charge screening and stress relaxation occur on atomic scale distances. In particular it has been recognized since a long time that a polar surface, i.e. a surface cut perpendicular to a direction along which the unit cell carries a net electric dipole moment, requires major rearrangements to solve the problem of the divergence of the electrostatic potential [14]. Several charge compensation mechanisms have been proposed to stabilize polar surfaces: purely electronic effects, modifications of the surface structure/stoichiometry or adsorption/segregation of charged species [15]. Moreover since the polarization and strain gradient can couple together at the surface through the flexoelectric effect, we can expect that surface modulations or ripples can be favored [16 and 17]. Therefore, surface studies may provide new insight into the fundamental properties of ferroelectric

Ferroelectric thin films are the object of intense fun- 46 materials and this point is all the more crucial that mass

Among ferroelectrics, a new class of materials with 51 high potentialities for spintronic applications has been 52 introduced and known as ferroelectric Rashba semicon-₅₃ ductors [20]. Major results have been obtained on α -54 GeTe thin films. It has been demonstrated the reversal 55 of the ferroelectric polarization under an electric field [21] 56 and a consistent change of the spin chirality of the band 57 structure [22 and 23]. The α -GeTe ferroelectric phase has 58 a rhombohedral structure (space group R3m) and bulk 59 Curie temperature of $T_c \sim 650-700$ K. The spontaneous 60 polarization of α -GeTe is along the pseudocubic < 111 >61 leading to the formation of 4 ferroelastic variants and 62 three possible polarization switching between domains at ₆₃ 71°, 109° or 180°. As reported by Wang et al. [24] α -64 GeTe thin films can be grown on Si(111) by molecular beam epitaxy with a quasi-single crystalline order using a 66 pre-deposition of 1 ML of Sb onto the substrate. Croes et ₆₇ al. [25] have shown that such α -GeTe thin film is an ideal 68 platform to study and control ferroelectric nanodomains 69 as they are no more limited by grain boundaries. The 70 α-GeTe thin films are made of main domains with a fer-71 roelectric polarization perpendicular to the surface, i.e. $_{72}$ in the [111] direction and called c-domains, and ferro-73 electric nanodomains with a majority of 71°-type domain valls and called hereafter a-domains. In this article we 75 address the surface morphology and structure of α -GeTe 76 thin films grown on Si(111). From low energy electron 77 microscopy (LEEM) and scanning tunneling microscopy 78 (STM) studies we show that α -GeTe thin films grow via79 a step-flow mode of Ge-Te bilayers. The growth velocity 80 is limited by the advance of step edges exhibiting tri-81 angular notches. Atomic details of the polar surface of ₈₂ α -GeTe indicate that the surface of the GeTe c-domains 83 is unreconstructed and Te-terminated. On the contrary 84 the polar surface of the ferroelectric a-domains exhibits 85 complex restructuring of the surface: a 2×2 surface reso construction that is Ge-terminated, a missing row recon87 struction and a large scale 2D structure ($\sim 4 \times 5 \text{ nm}^2$) that 138 88 stabilizes the surface. We show that these atomic rear-89 rangements involve large Te mass transfers.

EXPERIMENTAL SECTION

92 are first cleaned by acetone and ethanol rinsing before in- 148 spots for LEEM imaging (dark-field imaging mode) we ₉₆ during a few minutes in order to obtain a clean 7×7 ₁₅₂ indicate a majority epitaxy of α -GeTe (111)||Si(111) and 128 collected onto a 2D detector. The data analysis consists 184 direction, i.e. perpendicular to the film (q_z) is perpendicular. space coordinates [26]. The 3D reciprocal space maps 189 and $[\overline{1}11]_c$ in pseudo-cubic coordinates. The a-domains 134 have been visualized using the ParaView software. TEM 190 have a polarization direction at 71° with respect to the investigations were performed along $[1\overline{10}]$ zone axis at investigations were performed, i.e. mainly in-plane. This corroborates an accelerating voltage of 300 kV on a JEOL JEM-3010 102 the observation that GeTe films have a preferential out-

instrument with a spatial resolution of 0.17 nm.

RESULTS AND DISCUSSION

Growth and structure of a-nanodomains

The surface morphology of a 470 nm-thick GeTe thin film grown on Si(111) is observed by LEEM (figure 1(a)). 142 It shows extended flat areas separated by depressions and needle shape a-nanodomains extended in the $\langle 1\overline{1}0 \rangle$ direction in cubic coordinates of the Si substrate. The LEED pattern of the surface shows that the threefold symme-146 try (figure 1(b)-i) can be associated with the growth of Si(111) wafers (Siltronix; 550 μ m -thick; ρ =1-10 Ω cm) ₁₄₇ (111) planes of GeTe on Si(111). Using the diffracted troduction in ultra-high vacuum (UHV, 10^{-8} Pa). Then $_{149}$ see that only a small fraction of twinned grains are dethe substrates are degassed at 1000 K during 12 h fol- 150 tected at the surface of the thin film (ACB stacking inlowed by repeated high temperature annealing (1500 K) 151 stead of ABC, see figure 1(b)-ii and -iii). These results surface reconstruction. A deposition of 1 ML of Sb is $_{153}$ [$1\overline{10}$] $\|Si[1\overline{10}]$ [24]. We can also detect by LEEM typical performed on the Si(111) surface, forming the so-called 154 regular rows of defects on the terraces displaying a char- $Si(111)-\sqrt{3}\times\sqrt{3}$ -Sb reconstruction that greatly improves 155 acteristic bright/dark contrast (see dashed rectangles in the crystalline quality of the GeTe layer. The GeTe 156 figure 1(a)). These structures have a period L in the thin films are grown by co-deposition of Ge (1175 °C) 157 range 50-100 nm and extend over 0.2 - 1 μ m distance. and Te (310 °C) in UHV at 275°C and pre-characterized 158 They are characteristics of dislocations at small-angle by in situ RHEED. All the deposition sources are effu- 159 grain boundaries that are associated with an azimuthal sion cells from MBE-Komponenten Gmbh. After growth, 160 misorientation $\Delta\theta$ between two neighboring grains [27]. the GeTe layers are transferred under UHV conditions 161 From the periodicity of the defects we can estimate the lothanks to a homemade transfer suitcase and character- 162 cal misorientation of the lattices as $\Delta\theta \sim \frac{a}{L} \sim 0.2^{\circ} - 0.4^{\circ}$ ized by low energy electron microscopy (LEEM), low en- 163 that is within the expected angular range deduced from ergy electron diffraction (LEED) using a LEEM III mi- 164 X-ray measurements of the in-plane mosaicity [24]. The croscope (Elmitec GmbH) and scanning tunneling mi- 105 surface is also covered with elongated a-nanodomains. croscopy (STM) by a VT-STM (Omicron Gmbh). LEEM 166 These nanodomains appear as dark needles in bright images were obtained in bright field mode at an incident 167 field LEEM imaging mode since the reflected beams from electron energy of 26 eV where a local maximum of re- 168 these a-domains are angularly distant. Indeed the LEED flectivity occurs. At this energy the reflected electrons 169 pattern shows that the main reflected beam by the surby the GeTe c-domains and by the tilted ferroelectric 170 face is surrounded by three additional secondary reflected a-nanodomains are clearly separated in the focal plane. 171 beams (figure 1(e)). Since the angular shift of these This allows to use the smallest contrast aperture (\emptyset =10 ₁₇₂ beams increases with the incident electron energy, they μ m) to select only the reflected beam from the c-domains 173 correspond to tilted surface planes [28]. Croes et al. [25] (see Figure 1(a)). STM images were obtained at room 174 has shown that the tilt angle of the a-domains can be temperature in constant current mode with typical imag- 175 estimated as $1.4^{\circ} \pm 0.1^{\circ}$. These a-domains can also be ing conditions (U=-1 V, I= 20 pA, W tip). In situ STM 176 observed in bulk by cross-section TEM showing the prescharacterization of the a-nanodomains evolution under 177 ence of 71° -type domain walls (figure 1(c)). Moreover the thermal annealing were performed at constant tempera- 178 3D reciprocal space map measured by X-ray diffraction ture in the range 200-250 °C. The internal structure of 179 around the 222c Bragg peak (c stands for pseudo-cubic GeTe thin films has been studied by X-ray diffraction 100 coordinate) shows a splitting in four peaks. The major at BM32 beamline (ESRF) and High Resolution TEM. 181 peak is at the lowest q_z momentum transfer value (35.41 X-ray diffraction data have been measured at 18 keV ₁₈₂ nm⁻¹) and can be assigned to the GeTe c-domains with [0.06888 nm] with a beam size of $200 \times 300 \ \mu\text{m}^2$ and 183 a rhombohedral elongation of the unit cell in the [111] of a field correction (of the possible non-uniform response 185 ular to the surface). The three minor peaks are localized of the various pixels of the detector) and then a conver- 186 at higher q_z (36.73 nm⁻¹) and can be assigned to ferroesion of the measured data from the detector coordinates 187 lastic/ferroelectric a-nanodomains whose unit cells are (pixel index) to diffraction angles and thus to reciprocal 188 stretched in the three remaining directions $[11\overline{1}]_c$, $[1\overline{1}1]_c$ 193 of-plane ferroelectric self-poling state dominated by c-

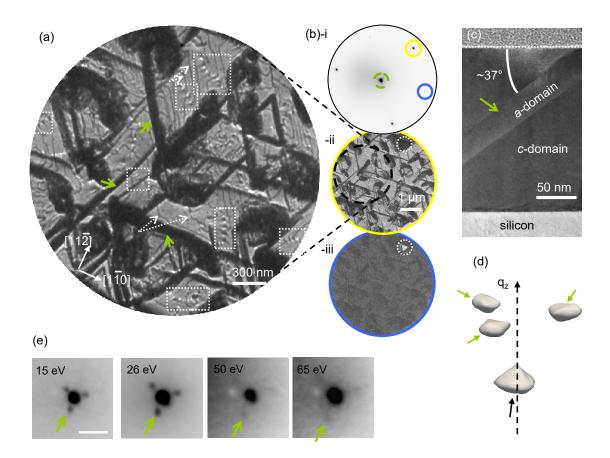


FIG. 1. (a) LEEM image of a 470 nm-thick GeTe thin film grown on Si(111)- $\sqrt{3} \times \sqrt{3}$ -Sb (Bright field mode, Electron energy: 26 eV). The contrast aperture selects only the reflected beam from the c-domains excluding the reflected beams from the a-nanodomains appearing as dark needles (green arrows). Row of defects from grain boundaries (see for instance in white dashed rectangles), ferroelectric a-nanodomains (green arrows), atomic steps (white dashed arrows). (b)-(i) LEED pattern of GeTe thin film (electron energy: 26 eV; incident beam diameter: $\emptyset=20~\mu\mathrm{m}$). The threefold symmetry of the pattern arises from the (111) surface structure of GeTe. (ii) LEEM image in dark field mode (Electron energy: 26 eV) selecting the most intense diffracted beam (yellow circle in (i)). (iii) LEEM image in dark field mode (Electron energy: 26 eV) selecting the less intense diffracted beam (purple circle in (i)). Twinned grain (white dotted circles in (ii) and (iii)).(c) TEM cross-section of a 200 nm-thick GeTe thin film with medium resolution ($[1\overline{1}0]$ zone axis). The green arrow show a a-nanodomain crossing the film. (d) iso-intensity representation (40000 counts) of a 3D reciprocal space map around $(00q_z)$ at $q_z \sim 36$ nm⁻¹ (film thickness 800 nm). The green arrows show the diffraction peaks from the a-domains. (e) Close view around the (00) reflected beam of a LEED pattern (electron energy: 26 eV) at incident electron energy E= 15, 26, 50 and 65 eV. The green arrows show the shift of the reflected beam by the a-domains with the incident electron energy.

194 domains [29].

fore during growth at 275° C the diffusion length of the 216 atoms at a bilayer step edge and not by successive growth species before nucleation of a 2D island is larger than 217 of Ge and Te layers. This step-flow mode is associated 203 the typical terrace width (>100 nm). To better charac- 218 with a well-defined orientation of atomic step edges with terize the growth process, figure 2(a) shows a large scale 219 ascending steps in the $\langle \overline{11}2 \rangle$ direction (figures 2(a)-(b)). 205 STM image $(2\times2~\mu\text{m}^2)$ of a 800-nm thick GeTe film. 220 Considering a (111)-oriented surface there exists two low-LEEM and STM show similar surface features (see sup- 221 energy step edges, the so-called A- and B-step edges 207 plementary material S1 [30]). The STM image derivative 222 (pseudo-fcc crystals), with in-plane orientations differing 208 in figure 2(b) highlights the a-nanodomains elongated in 223 by 60° [31]. Since B-step (resp. A-step) edges are as-

the $\langle 1\overline{1}0 \rangle$ direction since the surface plane is tilted. As In addition to domains and defects, LEEM measure- 210 for LEEM images, 3 domain orientations coexist. The ments also show that the GeTe surface is made of atom- 211 surface also shows the presence of atomic steps correically flat (111) terraces separated by atomic steps that 212 sponding to single Ge-Te bilayers (0.35 nm, inset in figare a few hundreds nanometers away. Since no island is visible on the terraces, this indicates that GeTe growth on GeTe. This observation demonstrates that the GeTe Si(111) occurs via a steady state step-flow mode. There- 215 growth proceeds via a direct incorporation of Ge and Te

224 cending (resp. descending) in the $\langle \overline{112} \rangle$ direction (figure 279 225 2(d)) thus the surface is dominated by B-step edges un-226 der growth conditions. From STM topography (see figure 227 2(e)) corresponding to an intermediary stage of thin film growth (before the steady state step-flow process) both step edges can be observed on the surface. We can notice that A-step edges are straight whereas triangular notches are formed on B-step edges (see figure 2(e)). Since at late stage of the growth, all step edges are B-type we can infer that A-step edges grow faster than B-type (figure 2(c)). The sketch of the atomic structure of the GeTe surface (figure 2(d)) shows that the A-step edge is made with a {100} microfacet whereas the B-step edge is made with a {111} microfacet. Therefore a A-step edge is stoichiometric in Ge-Te and is non-polar whereas a B-step edge is made of a single element and polar. Since B-step edges exhibit triangular notches, they spontaneously decompose into A-step edges and have a step edge termination without net charges. In addition the notches increase by a factor 2 the step edge length of B-steps with respect to a straight step edge, thus the growth rate of these notched B-step edge is reduced which favors their presence at the 246 surface during growth.

₂₅₇ face as the height profile in the neighborhood of the a-₃₁₄ (a'=b'=0.427 nm, angle=121.4°) whereas the c-domains 258 domains is non-symmetric (figure 2(e)-(f)). The surface 315 have a hexagonal unit cell (a=0.418 nm, b=0.418 nm, to the difference of (111) inter-reticular distance d₁₁₁ be- ³¹⁹ and considering the (111) cut plane. 276 side. The domain wall angle (37°) and the film height H 333 addition very close to the a-domain edge, the row struc-

Surface polarity of a-nanodomains

The ferroelectric a-nanodomains allow relaxing the in-281 ternal stress induced by the substrate into the GeTe thin 282 film [25]. In addition to the epitaxial stress at the interface, the free surface may also relax and this point is all the more crucial for polar surfaces [14]. However on the surface of the GeTe c-domains, that is polar, no sur-286 face reconstruction is detected by LEED or STM. This 287 result corroborates previous STM observations of the sur-288 face of GeTe [33] and DFT calculations that a pristine 289 (i.e. unreconstructed) Te-covered (111) surface is ener-290 getically favorable [32]. Considering the ferroelectric a-²⁹¹ nanodomains, microdiffaction measurements (μ -LEED, beam diameter $\emptyset=300$ nm) on one single a-nanodomain 293 give some information on the crystallographic structure 294 (figure 3(a)). First the shift of the reflected beam can be assigned to the local tilt angle ($\sim 1.5^{\circ} \pm 0.2^{\circ}$) of the 296 a-domain surface in the $[11\overline{2}]$ direction with respect to ₂₉₇ the GeTe c-domain [25]. This typical tilt angle is in ade-298 quation with the STM profile of the surface morphology (figure 2(f)) and corroborates macroscopic measurements 300 of the shift of the reflected beam by LEED (figure 1(e)). 301 Considering now the crystallographic lattice of the fer-302 roelectric domains, it appears that the diffracted spots 303 of the a-nanodomain do not coincide with those of the STM images reveal also that atomic steps are undis- 304 c-domains, even after correcting for the rigid shift due turbed by the ferroelectric a-domains (see figures 2(a)- 305 to the tilt angle (figure 3(a)). To avoid systematic er-(b) and (e)). This observation is fully consistent with 306 rors due to the distortion of the reciprocal space by the the result that the growth of GeTe thin films occurs 307 LEED setup we compare only the positions of the reciproat a sufficiently high temperature for the ferroelectric 308 cal lattice points of the a-nanodomain and the c-domain a-domains to be absent [25]. The a-nanodomains nu- a-so that are localized in the same reciprocal space area. The cleate and grow during cooling to room temperature af- 310 reciprocal lattice of the a-nanodomain is slightly comter thin film growth and do not modify the overall step 311 pressed by 2.2±0.2% in the [112] direction. We deduce organization. However the ferroelectric a-domains still 312 that the in-plane lattice of the a-nanodomain is a dishave an influence on the morphology of the GeTe sur- 313 torted hexagon (figure 3(b)) with a monoclinic unit cell of the GeTe c-domains is lower on one side of the a- 316 angle=120°). This result also perfectly matches the nanodomains (in the [112] direction) whereas it is higher 317 lattice of the GeTe a-nanodomains measured by X-ray and flat on the opposite side. This morphology is related 318 diffraction when these latter are elongated along [111]

tween the c-domains and the ferroelectric a-nanodomains as well as the penetration angle of the a-nanodomains 321 a polarization axis aligned along the normal to the surinside the GeTe film. The inter-reticular distances d_{111} 322 face and a threefold symmetry whereas the surface plane can be directly compared from the position of the 222_c 323 of the a-nanodomains has a twofold symmetry axis. In Bragg peaks measured by X-ray diffraction (figure 1(d)). 324 addition the surface normal of the a-nanodomains is not They provide a quantitative estimate of the compression 325 parallel to the elongation axis of the rhombohedron but of the (111) crystallographic planes (3.74%) inside the $_{326}$ tilted by $\sim 71^{\circ}$. To address the surface relaxation mechanical relaxation $_{326}$ a-nanodomains with respect to the c-domains. Since the a-nanodomains of the polar a-nanodomains, we have performed a-nanodomains penetrate with a definite angle inside the $_{328}$ high resolution STM images. Surface images of a 800 film (see TEM in figure 1(c) for the 71° -type domain $_{329}$ nm-thick GeTe thin film show different features (figures wall), then the lowering effect measured on the GeTe sur- $_{330}$ 4(a)-(b)). Flat areas are visible in the middle of the aface of c-domains occurs on one side, i.e. above the fer- 331 domain and regular rows are formed along the long side roelectric a-nanodomains, while it is absent on the other a-domain, i.e. parallel to the [110] direction. In provide a typical distance W over which the deformation $_{334}$ ture changes to a two dimensional structure described as of the GeTe surface extends $W \sim \frac{H}{\tan(37^\circ)} \sim 1.3H$.

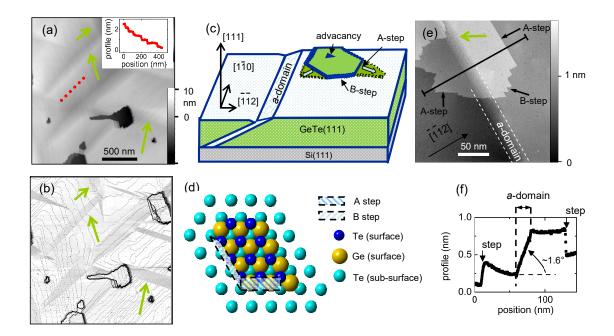


FIG. 2. (a) Large scale STM image of a 800 nm-thick GeTe thin film grown on Si(111)- $\sqrt{3} \times \sqrt{3}$ -Sb (U= -1V; I= 20 pA). Green arrows show ferroelectric a-nanodomains. Inset: profile on STM image (a) along dashed lines showing atomic steps at the surface (1 GeTe Bilayer (BL)=0.35 nm). (b) Image derivative of (a) to highlight ferroelectric a-nanodomains and atomic steps. (c) Scheme of the surface morphology of GeTe thin films on Si(111). (d) Scheme of A-step and B-step edge models. (e) Close view by STM of a 80 nm-thick GeTe thin film grown on Si(111)- $\sqrt{3} \times \sqrt{3}$ -Sb (U=-1V; I= 20 pA). Ferroelectric α -domains (green arrow and dotted guide lines), A-step and notched B-step edges (black arrows). (f) profile on STM image (e) (arrow: inclined profile due to the a-domain tilt).

336 tion at the surface of the a-nanodomains we can compare 364 kinetically, the surface termination of the ferroelectric a-337 the surface profiles of a- and c-domains. The flat areas 365 nanodomains changes with a well defined process: (i) At 338 of a-nanodomains are ~ 150 pm below the surface of c-366 first cooling, i.e. just after thin film growth, and for large 340 atomic spacing of the short Ge-Te bond [32]. Since c- 368 show extended flat areas that are thus Ge-terminated. 346 odicity of 5.1 ± 0.2 nm (figure 4(c)). This height modu-375 be counter-intuitive considering surface energies [32]. In (see figure 4(b)).

Based on our STM observations we have found that 392 lar or alpha reconstructions [38-41]. The octopolar re-

domains. This height corresponds approximately to the 367 a-domains (>100 nm width), the surface of a-domains domains are known to be Te-terminated, as deduced from 369 (ii) Upon annealing, the surface of the domains equi-XPS measurements [22] and surface energy minimization 370 librate by forming first a row structure (missing row calculations [32], then the flat areas of a-nanodomains 371 reconstruction) and then (iii) a scales pattern that ormust be Ge-terminated. Concerning the row structure, 372 ders at long distance. The initial stability of the Geit has a height modulation of 150± 20 pm and a peri- 374 terminated flat areas in the middle of the a-domains may lation can be attributed to a missing row reconstruction 376 figures 5-(a)-(b) is shown an atomically-resolved STM of Te. Such a 1D surface modulation is consistent with 377 image of a Ge-terminated flat area in the middle of a athe translation invariance of the c-domains along the long 378 nanodomain. From the Fourier Transform of the height axis of the needle, i.e. in the $[1\overline{1}0]$ direction. This miss- 370 of the flat area we can measure a hexagonal like pattern ing row reconstruction is also observed in the context of 380 and a surface unit cell that is four times larger than the metal surfaces with or without adsorption of adspecies 381 GeTe(111)-(1×1) bulk terminated unit cell. Complemen-(Pt(110) [34], Au(110) [35], O/Pd(110) [36]). The 2D ₃₈₂ tary μ -LEED pattern at 6 eV incident energy shows that scales structure observed initially close to the domain 383 the surface is indeed 2×2 reconstructed and dark-field edge in figure 4(b) tends to cover the entire a-domain $_{384}$ imaging with a 2×2 diffracted beam localizes the reconsurface after long annealing at 200° C under UHV and 385 struction on the a-nanodomains corroborating the STM forms a highly regular 2D network. The scales structure 386 analysis (figure 5-(c)). This type of surface reconstrucis made of missing Te rows in 2 directions. In addition 387 tion has been suggested on a similar IV-VI semiconductor triangular holes corresponding to GeTe bilayer vacancies 388 system PbTe(111) by Rutherford Back Scattering meacan be found (\sim 320± 50 pm). They preferentially occur 389 surements [37]. A 2×2 reconstruction has also been proin between Te scales or at the side of missing rows of Te 300 posed to neutralize polar surfaces in the context of ionic materials or semiconductors and is known as the octopo-

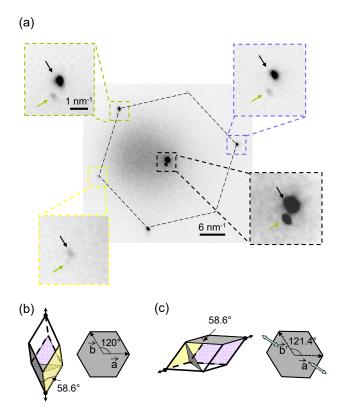


FIG. 3. (a) μ -LEED pattern of a GeTe thin film (800 nmthick). The incident beam diameter is $\emptyset=300$ nm and the electron energy E=26 V. The incident beam illuminates one ferroelectric a-nanodomain and the surrounding GeTe layer. The hexagonal pattern of GeTe surface structure of the cdomain is detected (dashed hexagon). Insets: close views of reflected and diffracted spots. All spots are split into a major peak (black arrow) coming from the GeTe c-domain layer and a minor peak (green arrow) arising from the ferroelectric adomain. The shift between the major and minor peaks is not a simple translation but changes with the selected diffracted spot). (b) Scheme of the crystallographic structure of GeTe c-domain and hexagonal surface lattice. (c) Same as (b) for a ferroelectric a-domain.

393 construction [42] is a pyramid-like structure obtained by keeping one quarter of atoms from the surface layer and three quarters of atoms from the subsurface layer. The alpha reconstruction derives from the octopolar one by removing the last atom of the surface layer (see geometrical model in figure 5-(d)). From the analysis of the STM images that indicates a Ge-terminated surface it is the alpha reconstruction that is observed on the a-domains surmost stable (surface energy: 1.5-2.1 eV.nm⁻²) and is ob- 414 B-step edges on the GeTe c-domains (see figure 4-(a) at 407 served on the (111)-GeTe c-domains, it appears not to be 415 the top). This reinforces the proposal that the 2×2 surthe case on the a-nanodomains. We can notice that this 416 face reconstruction neutralizes the surface charges. The

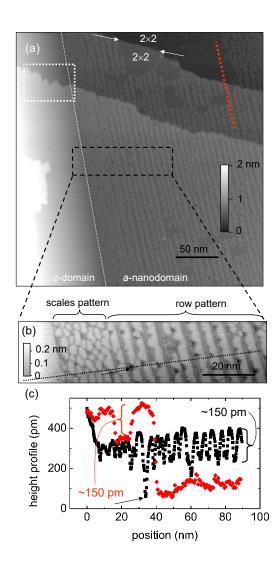


FIG. 4. (a) STM image (U= -1V; I= 20 pA) of the GeTe surface morphology (800 nm-thick film). A ferroelectric a-domain is on the right and the GeTe c-domain on the left. Flatness is imposed on the a-domain surface. Notched step-edge on the main GeTe layer (white dashed rectangle). Straight step-edge inside a 2×2 reconstructed area on the ananodomain (in between white arrows). (b) STM image (U= -1V; I= 20 pA) of the ferroelectric a-domain (from dashed rectangle on image (a)) with row and scale patterns. Black arrow shows a GeTe bilayer vacancy island. (c) STM height profiles along the 2×2 reconstruction (red doted line in (a)) and row pattern (black doted line in (b)). The black arrow shows the dip into the profile at the bilayer vacancy island in

face. In addition Deringer et al. has theoretically shown 400 2×2 reconstruction induces a drastic change in the chem-[32] that the alpha and octopolar reconstructions have 410 ical termination of the surface (Ge) and stoichiometry similar surface energies on a polar (111)-GeTe surface 411 (Ge₃Te₄) that may deeply modify the electronic proper-(respectively 3.4-3.7 and 3.5 eV.nm⁻²). Despite the fact 412 ties. In that respect we can also notice that B-step edges that the Te-terminated unreconstructed surface is the 413 crossing flat 2×2 zones have no notch on the contrary to

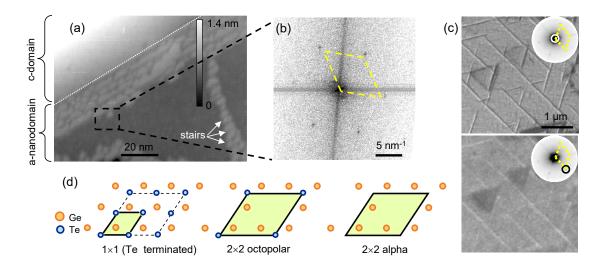


FIG. 5. (a) STM image of the surface of a a-nanodomain of a 1500 nm-thick GeTe thin film grown on Si(111)- $\sqrt{3} \times \sqrt{3}$ -Sb (U=-1V; I= 20 pA). (b) FFT of a high resolution STM image of the flat area of a a-nanodomain showing a 2D hexagonal lattice. (c) Bright-field (top) and dark-field (bottom) LEEM images at 6 eV of a 460 nm-thick GeTe thin film. The bright field mode is obtained selecting the reflected beams from both c- and a-domains (white circle in LEED pattern). The a-domains appear with a bright-dark contrast due to the hill-and-valley morphology (titled surface) and focusing conditions (see [45] and supplementary materials S7 and S8 in [25]). The dark field image is obtained selecting a 2×2 spot (dark circle in LEED pattern). Inset: μ -LEED patterns showing fine 2×2 spots from a 2×2 surface reconstruction. (d) Geometric model of the surface structure of a flat zone: 1×1 Te-terminated, 2×2 octopolar reconstruction; and 2×2 alpha reconstruction.

417 row pattern (Te-terminated) on the a-domains could be 448 Therefore the Te/Ge adatom ratio on the surface during 418 considered as a 12×1 surface reconstruction and may be 449 deposition is slightly below 1. When growth is stopped 419 compared to the 2×1 reconstruction (spinel reconstruc- 450 and temperature decreased to room temperature, ferro-420 tion) as also theoretically predicted on polar (111)-GeTe 451 electric a-domains nucleate and grow. This process is 424 domain width (see figure 5-(a)). This growth mechanism 455 the global tensile stress by expanding the in-plane lattice 6-(b)) show that this reconstruction has a very large unit 470 infer that the Te atoms segregate from the domain walls. 440 cell ($\sim 4 \times 5 \text{ nm}^2$). We can deduce from the height pro-441 file that the surface is Te-terminated with missing rows in two directions. To understand the observed changes 443 of reconstructions we infer that the 2×2 reconstruction 471 and missing row pattern are metastable surface phases in-445 duced by a lack of Te. Indeed as Te is much more volatile 472 446 than Ge [46 and 47] we can expect that adsorbed Te onto 473 ture of the polar surface of ferroelectric GeTe thin films 447 the surface is the minority species during GeTe growth. 474 epitaxially grown on Si(111). The surface of the ferro-

surfaces [32] and detected by RHEED measurements on 452 due to the different linear expansion coefficients of GeTe PbTe(111) thin films [43 and 44]. This reconstruction 453 and Si that induce a thermo-mechanical stress inside the grows from the a-domain edges via stairs crossing the a- 454 film [25]. The occurrence of the a-nanodomains relaxes shows that the advance of the reconstruction onto the 456 parameter. Such a process only involves local rearrangesurface is favored by the local environment of the atoms. 457 ments of atomic positions and the kinetics is expected to At last the scales pattern is a stable reconstruction that 458 be much faster than mass transfers by diffusion. Consestays onto the a-domains surface whatever further an- 459 quently it does not provide enough time for the species nealing or cooling processes. In figure 6-(a) is shown the 400 to diffuse over large distances and optimize all surface surface of a GeTe a-nanodomain held at 220° C. The 461 structures. As the surface of the a-nanodomains and domain surface shows a regular pattern of scales which 462 c-domains are in competition for Te, we observe that periodicity increases with temperature whereas the GeTe 463 Te free adatoms cover primarily the c-domains. The c-domains keep an unreconstructed surface with triangu- 464 a-nanodomains surface is therefore Ge-terminated and lar advacancy islands coming from the GeTe congruent 465 forms the 2×2 alpha reconstruction. After annealing the sublimation. The step edge retraction phenomena fa- 466 surface of a-nanodomains equilibrates via Te bulk diffuvors the fastest step edges in terms of kinetics of mass 467 sion and forms successively a missing row reconstruction transfers, i.e. A-step edges that are straight and neu- 400 and a scales structure that are more and more Te-rich. tral. Atomically-resolved STM images of scales (figure 400 As the structures change from the domain edges we can

III. CONCLUSION

In conclusion we have studied the growth and the stru-475 electric c-domains of GeTe has a rhombohedral elonga-

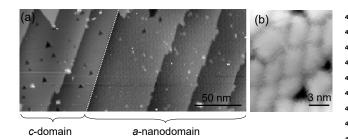


FIG. 6. (a) Large view STM image of the surface of a ananodomain of a 800 nm-thick GeTe thin film under annealing at 220° C (a-nanodomain on the right side of the dashed line). (b) High resolution STM image at RT of the scales structure onto a a-nanodomain surface. U= -1V; I= 20 pA.

476 tion perpendicular to the surface and is unreconstructed. 499 (CP2M, Marseille, France) for lamella preparation of is monoclinic and slightly tilted by 1.4° with respect to 503 fruitful discussions on ferroelectrics.

481 the c-domains. The surface structure and polarity relax via a complex reorganization of surface atoms: a 2×2 al-483 pha reconstruction, a missing row reconstruction and a 484 2D modulated structure form successively upon anneal-485 ing. These surface relaxations release the surface energy 486 involved in this low symmetry polar surface exhibiting 487 a monoclinic unit cell and mainly a planar polarization. 488 Our experimental measurements can be used as a play-489 ground to control ferroelectric domains and polarity in 490 GeTe that will help to tune the surface Rashba effect via surface reconstructions.

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